


<b>Search Notes</b> 	<b>Application/Control No.</b> 10537306	<b>Applicant(s)/Patent Under Reexamination</b> BRIQUE ET AL.
	<b>Examiner</b> SHIN-HON CHEN	<b>Art Unit</b> 2431

SEARCHED			
Class	Subclass	Date	Examiner
380	231,239	7/5/07	S.C.
713	193	7/5/07	S.C.

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	7/5/07	S.C.
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - updated search)	8/2/08	S.C.
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - updated search)	9/20/09	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--